

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination ATARASHI ET AL.	
			Examiner Bai D. Vu	Art Unit 2109	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,856,892 B2	02-2005	Oda et al.	701/202
*	B	US-2004/0203916 A1	10-2004	Chun et al.	455/456.1
*	C	US-2004/0088110 A1	05-2004	Suzuki, Keizo	701/211
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*Translation*

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002286479	10-2002	Japan	Shinozaki Hitoshi	Translation - STIC
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.